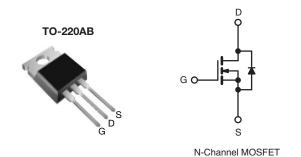


### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.85			
Q <sub>g</sub> (Max.) (nC)	38			
Q <sub>gs</sub> (nC)	9.0			
Q <sub>gd</sub> (nC)	18			
Configuration	Single			



### **FEATURES**

• Low Gate Charge Qq Results in Simple Drive



- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

### **TYPICAL SMPS TOPOLOGIES**

- Two Transistor Forward
- Half Bridge
- Full Bridge

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF840APbF		
Lead (Fb)-liee	SiHF840A-E3		
SnPb	IRF840A		
SHED	SiHF840A		

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		$V_{DS}$	500	V		
Gate-Source Voltage			$V_{GS}$	± 30	7 v	
Continuous Drain Current	V at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		8.0		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	5.1	А	
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	32			
Linear Derating Factor			1.0	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	510	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	8.0	А		
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$		$P_{D}$	125	W		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s			-	300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque			-	1.1	N⋅m	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 16 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 8.0 A (see fig. 12).
- c.  $I_{SD} \le 8.0$  A,  $dI/dt \le 100$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0	

PARAMETER	SYMBOL	TEST (	CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static						·		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	500	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.58	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 100	nA	
Zara Cata Vallana Duain Correct		V <sub>DS</sub> = 50	00 V, V <sub>GS</sub> = 0 V	-	-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	5 Ω	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.8 A <sup>b</sup>	-	-	0.85	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50	0 V, I <sub>D</sub> = 4.8 A <sup>b</sup>	3.7	-	-	S	
Dynamic						,		
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1018	-		
Output Capacitance	C <sub>oss</sub>			-	155	-		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	8.0	-		
Output Capacitance	C <sub>oss</sub>	f = 1.0 MHz, see fig. 5			– pF			
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}; V_{DS}$	s = 400 V, f = 1.0 MHz		42			
Effective Output Capacitance	C <sub>oss</sub> eff.	V <sub>GS</sub> = 0 V; \	V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>		56			
Total Gate Charge	Qg			-	-	38		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	9.0	nC	
Gate-Drain Charge	Q <sub>gd</sub>	1	geo ng. o ana ro	-	-	18		
Turn-On Delay Time	t <sub>d(on)</sub>			-	11	-		
Rise Time	t <sub>r</sub>	$V_{GS} = 10 \text{ V}$ $V_{DS} = 400 \text{ V}$ , see fig. 6 and 13b $-$ 18 $-$ 11 $-$ 12 $-$ 23 $-$ 24 $-$ 25 $-$ 27 $-$ 28 $-$ 29 $-$ 29 $-$ 29 $-$ 29 $-$ 29 $-$ 20 $-$		-	]			
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 9.1 \Omega$ , $R_D = 31 \Omega$ , see fig. 10 <sup>b</sup> - 26 - 19		-	ns			
Fall Time	t <sub>f</sub>			-	19	-		
Drain-Source Body Diode Characteristic	s	·						
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	8.0	- A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction did	ode	ı	-	32		
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I	$I_S = 8 \text{ A}, V_{GS} = 0 \text{ V}^b$	-	-	2.0	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C ! -	8 A, dl/dt = 100 A/µsb	-	422	633	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1J=25 C, I <sub>F</sub> =	ο A, αί/αι = 100 A/μS <sup>5</sup>	-	2.16	3.24	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	on time is negligible (turr	-on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

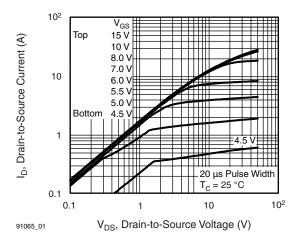


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

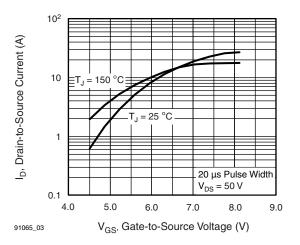


Fig. 3 - Typical Transfer Characteristics

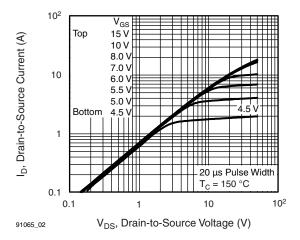


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

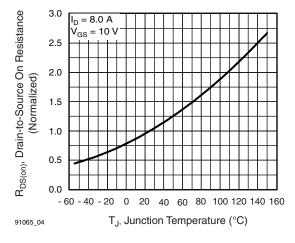


Fig. 4 - Normalized On-Resistance vs. Temperature



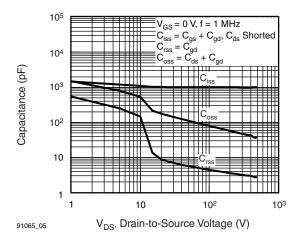


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

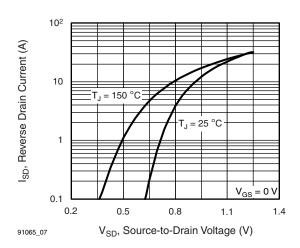


Fig. 7 - Typical Source-Drain Diode Forward Voltage

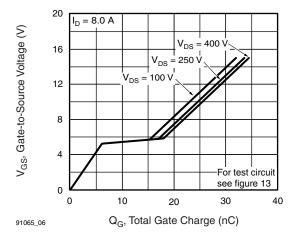


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

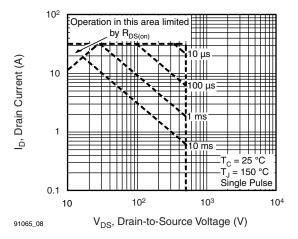


Fig. 8 - Maximum Safe Operating Area





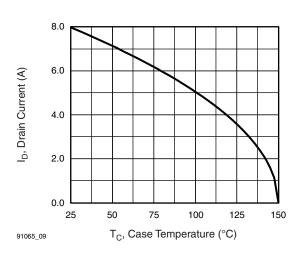


Fig. 9 - Maximum Drain Current vs. Case Temperature

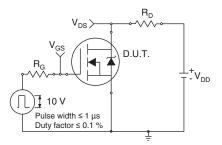


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

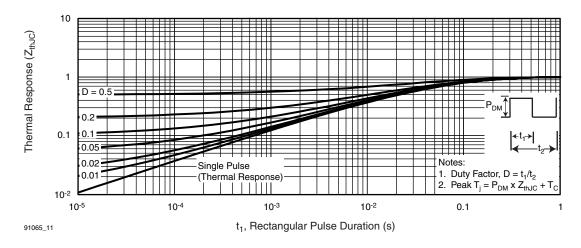


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



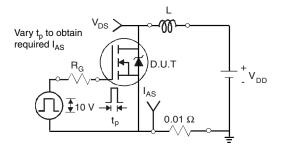


Fig. 12a - Unclamped Inductive Test Circuit

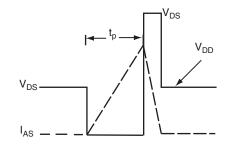


Fig. 12b - Unclamped Inductive Waveforms

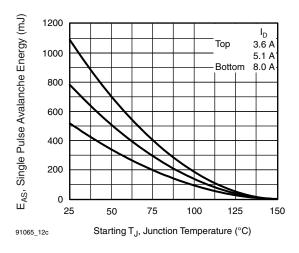


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

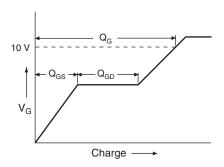


Fig. 12d - Basic Gate Charge Waveform

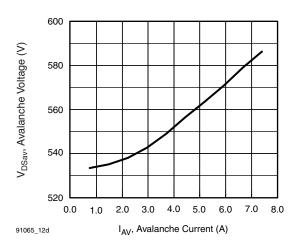


Fig. 13a - Typical Drain-to-Source Voltage vs. **Avalanche Current** 

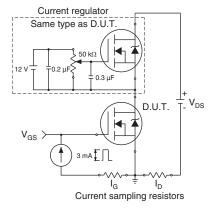
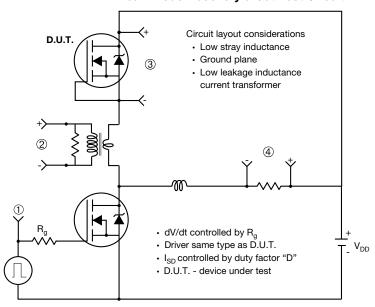


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



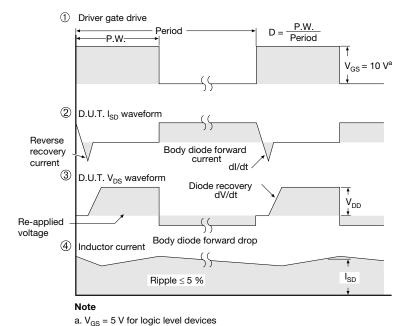


Fig. 14 - For N-Channel

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### TO-220-1



DIM.	MILLIN	METERS	INCHES		
DIIVI.	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	

#### Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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